

Product Summary

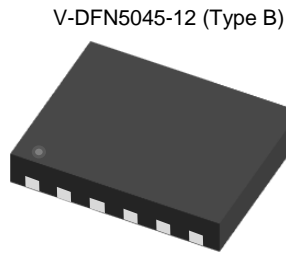
| BV _{DSS} | R _{DS(ON)} | I _D T _A = +25°C |
|-------------------|-------------------------------|--|
| 60V | 22mΩ @ V _{GS} = 10V | 10.6A |
| | 30mΩ @ V _{GS} = 4.5V | 8.7A |

Description

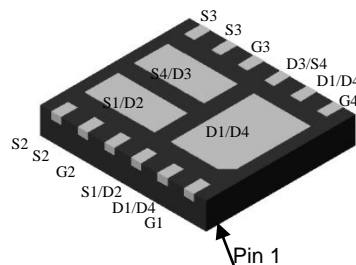
This new generation complementary MOSFET H-Bridge features low on-resistance achievable with low gate drive.

Applications

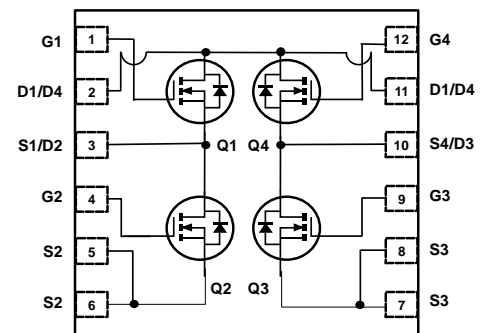
- Motor Control
- DC-DC Converters
- Power Management



Top View



Bottom View



Internal Schematic

Features

- Thermally Efficient Package – Cooler Running Applications
- High Conversion Efficiency
- Low R_{DS(ON)} – Minimizes On-State Losses
- Low Input Capacitance
- Fast Switching Speed
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**

Mechanical Data

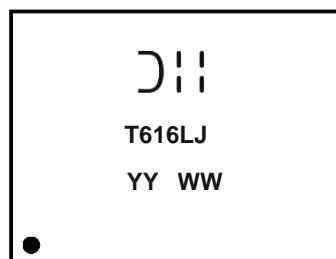
- Case: V-DFN5045-12 (Type B)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 0.097 grams (Approximate)

Ordering Information (Note 4)

| Part Number | Case | Packaging |
|----------------|-----------------------|-------------------|
| DMHT6016LFJ-13 | V-DFN5045-12 (Type B) | 3,000/Tape & Reel |

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
 4. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

Marking Information



= Manufacturer's Marking
 T616LJ = Product Type Marking Code
 YYWW = Date Code Marking
 YY = Last Two Digits of Year (ex: 16 = 2016)
 WW = Week Code (01 to 53)

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Value | Unit |
|---|--------------------------------|------------------------|------|
| Drain-Source Voltage | V _{DSS} | 60 | V |
| Gate-Source Voltage | V _{GSS} | ±20 | V |
| Continuous Drain Current (Note 6) V _{GS} = 10V | Steady State I _D | T _A = +25°C | 10.6 |
| | | T _A = +70°C | 8.5 |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%) | t<10s I _D | T _A = +25°C | 14.8 |
| | | T _A = +70°C | 11.9 |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%) | I _{DM} | 60 | A |
| Maximum Continuous Body Diode Forward Current (Note 6) | I _S | 2 | A |
| Avalanche Current (Note 7) L=0.1mH | I _{AS} | 15.3 | A |
| Avalanche Energy (Note 7) L=0.1mH | E _{AS} | 11.7 | mJ |

Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--|-----------------------------------|-------------|------|
| Total Power Dissipation (Note 5) | P _D | 1.16 | W |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady State R _{θJA} | t<10s | 108 |
| | | | 56 |
| Total Power Dissipation (Note 6) | P _D | 2.7 | W |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady State R _{θJA} | t<10s | 46 |
| | | | 24 |
| Thermal Resistance, Junction to Case (Note 6) | R _{θJC} | 4.4 | °C/W |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|--|---------------------|-----|------|------|------|--|
| OFF CHARACTERISTICS (Note 8) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 60 | — | — | V | V _{GS} = 0V, I _D = 250µA |
| Zero Gate Voltage Drain Current | I _{DSS} | — | — | 1 | µA | V _{DS} = 48V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±100 | nA | V _{GS} = ±20V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 8) | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | 1 | — | 3 | V | V _{DS} = V _{GS} , I _D = 250µA |
| Static Drain-Source On-Resistance | R _{DS(ON)} | — | 17 | 22 | mΩ | V _{GS} = 10V, I _D = 10A |
| | | — | 22.2 | 30 | | V _{GS} = 4.5V, I _D = 6A |
| Diode Forward Voltage | V _{SD} | — | 0.7 | 1.2 | V | V _{GS} = 0V, I _S = 1A |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | |
| Input Capacitance | C _{ISS} | — | 864 | — | pF | V _{DS} = 30V, V _{GS} = 0V, f = 1MHz |
| Output Capacitance | C _{OSS} | — | 282 | — | | |
| Reverse Transfer Capacitance | C _{RSS} | — | 27 | — | | |
| Gate Resistance | R _G | — | 1.3 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1MHz |
| Total Gate Charge (V _{GS} = 4.5V) | Q _G | — | 8.4 | — | nC | V _{DS} = 30V, I _D = 10A |
| Total Gate Charge (V _{GS} = 10V) | Q _G | — | 17 | — | | |
| Gate-Source Charge | Q _{GS} | — | 3.1 | — | | |
| Gate-Drain Charge | Q _{GD} | — | 4.3 | — | | |
| Turn-On Delay Time | t _{D(ON)} | — | 3.4 | — | ns | V _{GS} = 10V, V _{DS} = 30V, R _G = 6Ω, I _D = 10A |
| Turn-On Rise Time | t _R | — | 5.2 | — | | |
| Turn-Off Delay Time | t _{D(OFF)} | — | 13 | — | | |
| Turn-Off Fall Time | t _F | — | 7 | — | | |
| Reverse Recovery Time | t _{RR} | — | 22 | — | ns | I _F = 10A, di/dt = 100A/µs |
| Reverse Recovery Charge | Q _{RR} | — | 11 | — | nC | |

- Notes:
- Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
 - Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1-inch square copper plate.
 - I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to product testing.

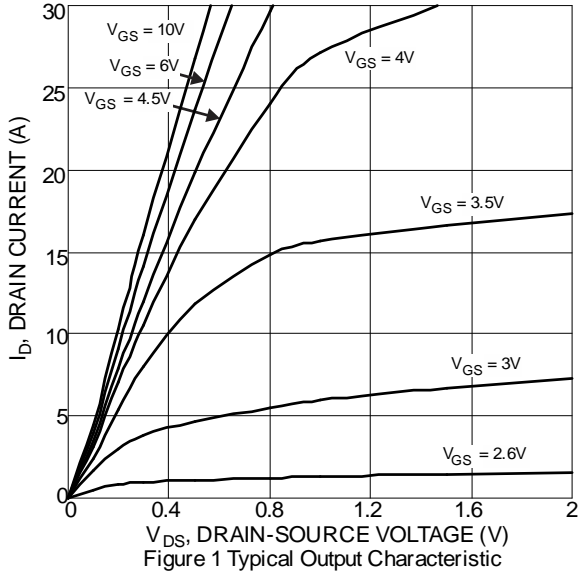


Figure 1 Typical Output Characteristic

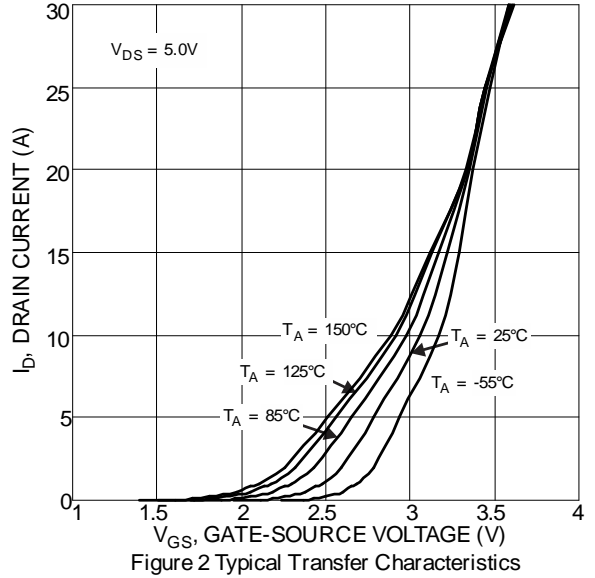


Figure 2 Typical Transfer Characteristics

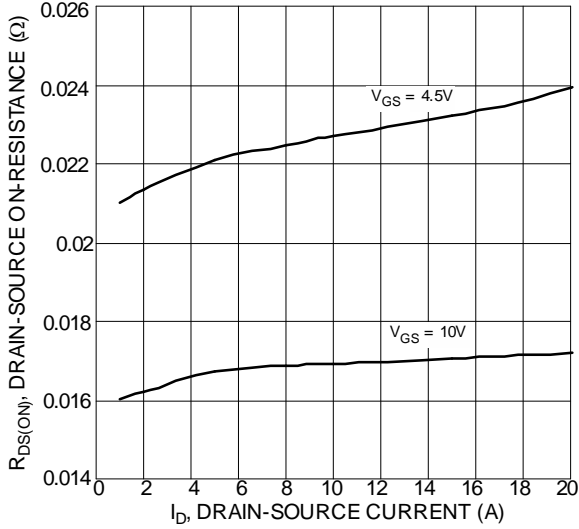


Figure 3 Typical On-Resistance vs. Drain Current and Gate Voltage

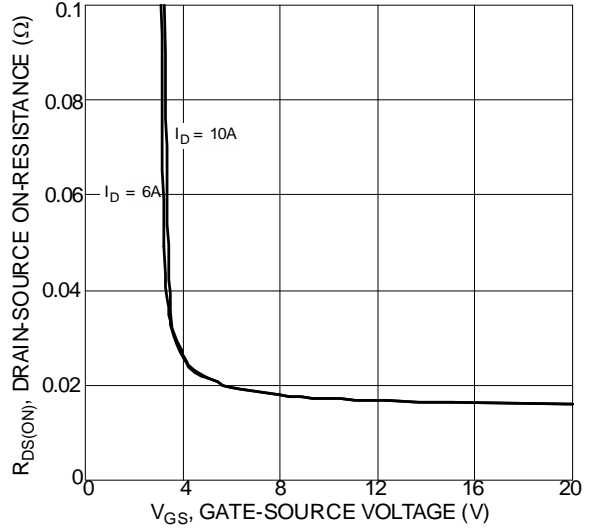


Figure 4 Typical Drain-Source On-Resistance vs. Gate-Source Voltage

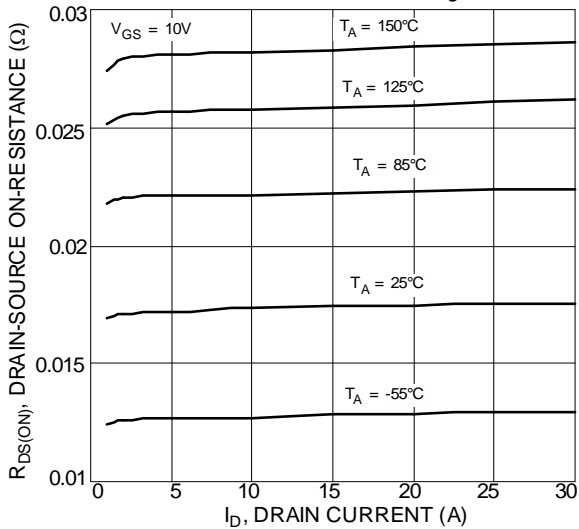


Figure 5 Typical On-Resistance vs. Drain Current and Temperature

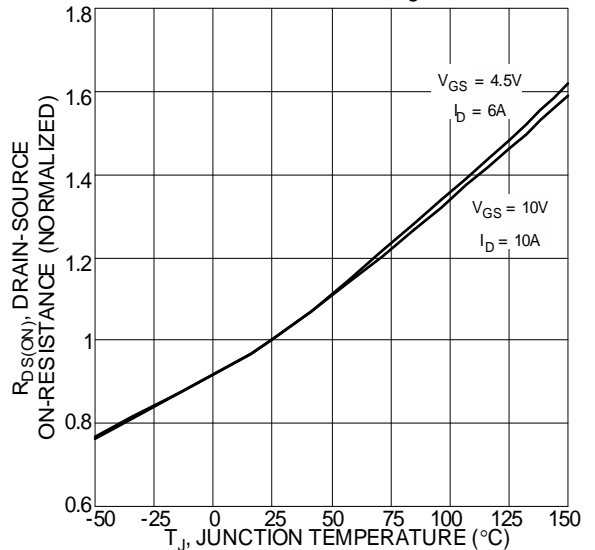


Figure 6 On-Resistance Variation with Temperature

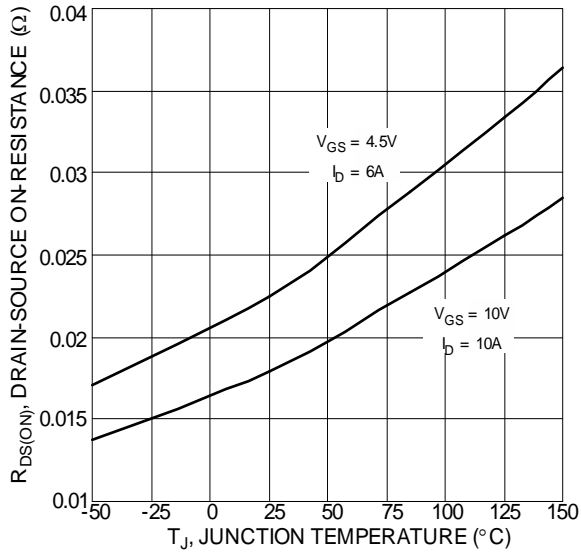


Figure 7 On-Resistance Variation with Temperature

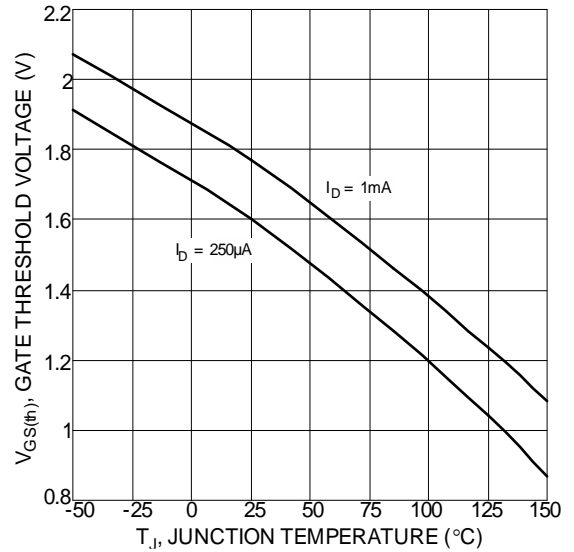


Figure 8 Gate Threshold Variation vs. Temperature

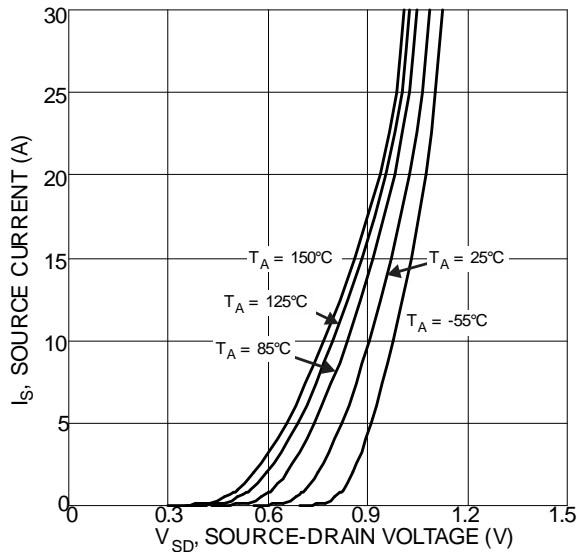


Figure 9 Diode Forward Voltage vs. Current

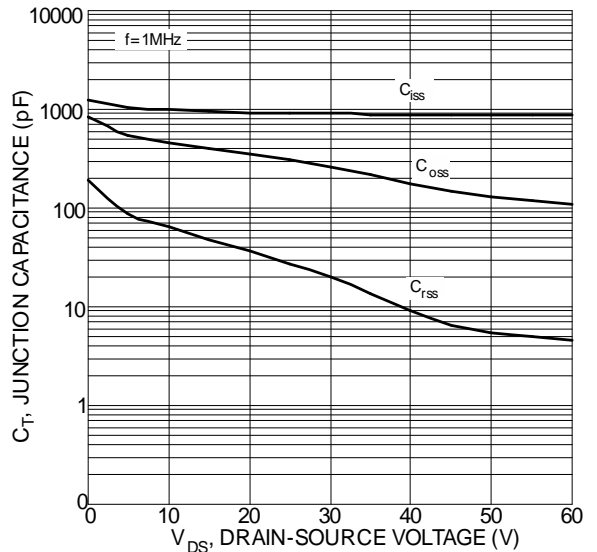


Figure 10 Typical Junction Capacitance

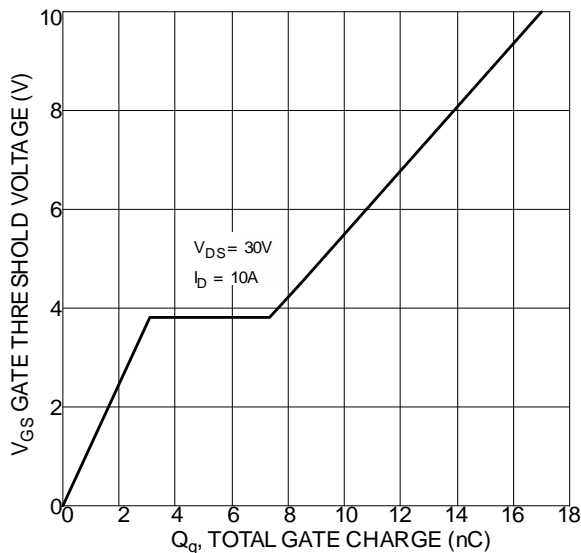


Figure 11 Gate Charge

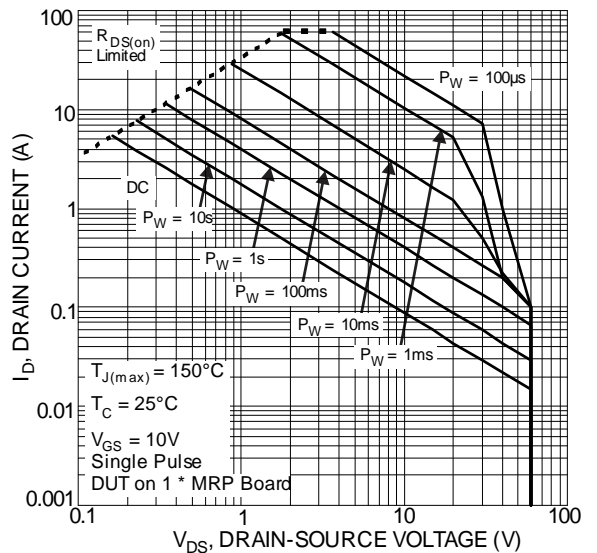
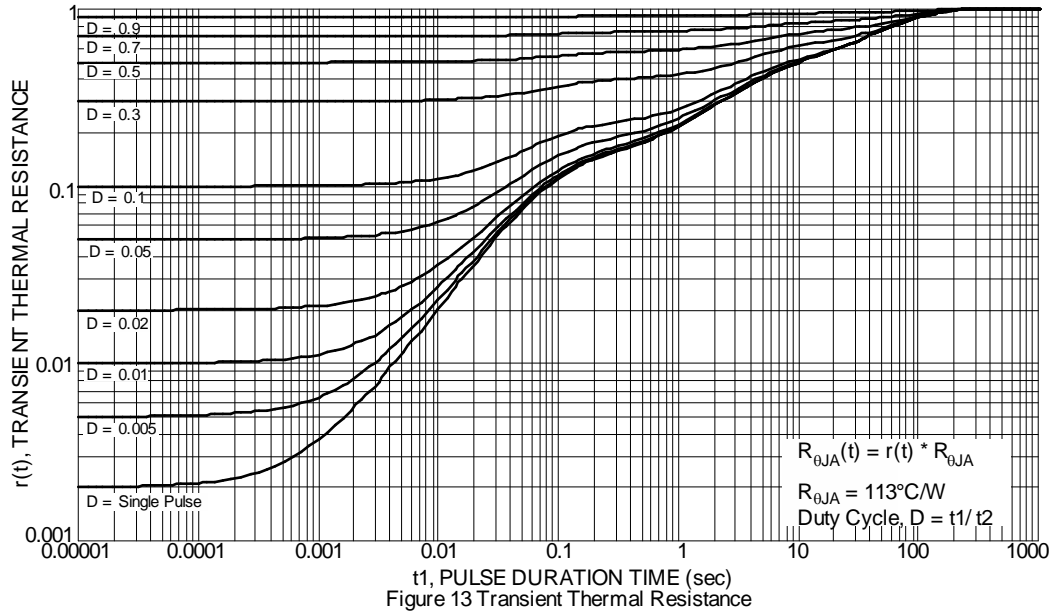


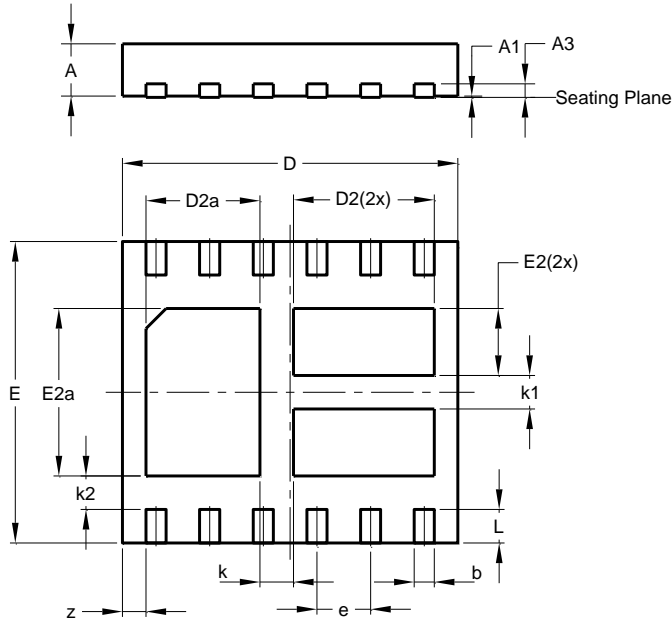
Figure 12 SOA, Safe Operation Area



Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

V-DFN5045-12 (Type B)



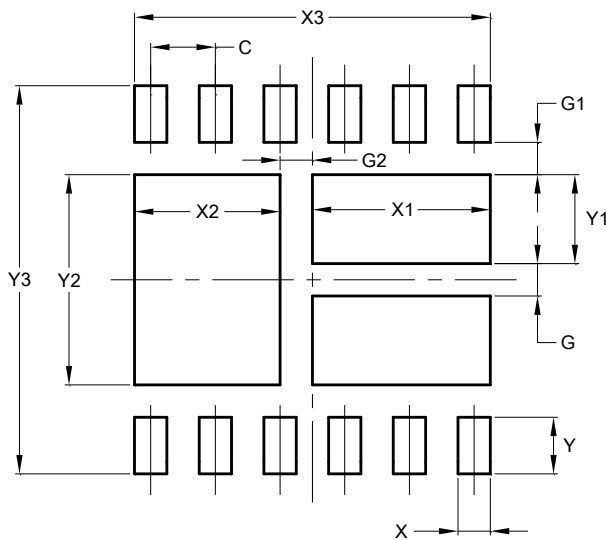
| V-DFN5045-12 (Type B) | | | |
|-----------------------|------|------|-------|
| Dim | Min | Max | Typ |
| A | 0.75 | 0.85 | 0.80 |
| A1 | 0.00 | 0.05 | 0.02 |
| A3 | - | - | 0.203 |
| b | 0.25 | 0.35 | 0.30 |
| D | 4.95 | 5.05 | 5.00 |
| D2 | 2.00 | 2.20 | 2.10 |
| D2a | 1.60 | 1.80 | 1.70 |
| E | 4.45 | 4.55 | 4.50 |
| E2 | 0.90 | 1.10 | 1.00 |
| E2a | 2.40 | 2.60 | 2.50 |
| e | - | - | 0.80 |
| k | - | - | 0.50 |
| k1 | - | - | 0.50 |
| k2 | - | - | 0.50 |
| L | 0.45 | 0.55 | 0.50 |
| z | - | - | 0.35 |

All Dimensions in mm

Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

V-DFN5045-12 (Type B)



| Dimensions | Value (in mm) |
|------------|---------------|
| C | 0.800 |
| G | 0.40 |
| G1 | 0.40 |
| G2 | 0.40 |
| X | 0.40 |
| X1 | 2.20 |
| X2 | 1.80 |
| X3 | 4.40 |
| Y | 0.700 |
| Y1 | 1.100 |
| Y2 | 2.600 |
| Y3 | 4.800 |

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